# FAIRCHILD

SEMICONDUCTOR®

# FQB34P10TM\_F085 100V P-Channel MOSFET

### **General Description**

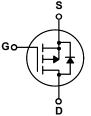
These P-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for low voltage applications such as audio amplifier, high efficiency switching DC/DC converters, and DC motor control.

## Features

- -33.5A, -100V,  $R_{DS(on)} = 0.06\Omega @V_{GS} = -10 V$
- Low gate charge (typical 85 nC)
- Low Crss ( typical 170 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability
- 175°C maximum junction temperature rating
- Qualified to AEC Q101
- RoHS Compliant





## Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		FQB34P10TM_F085	Units
V <sub>DSS</sub>	Drain-Source Voltage		-100	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°C)		-33.5	А
	- Continuous (T <sub>C</sub> = 100°C)		-23.5	А
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	-134	А
V <sub>GSS</sub>	Gate-Source Voltage		± 25	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	2200	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	-33.5	А
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	15.5	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	-6.0	V/ns
P <sub>D</sub>	Power Dissipation (T <sub>A</sub> = 25°C) *		3.75	W
2	Power Dissipation $(T_C = 25^{\circ}C)$		155	W
	- Derate above 25°C		1.03	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +175	°C
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

## **Thermal Characteristics**

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.97	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

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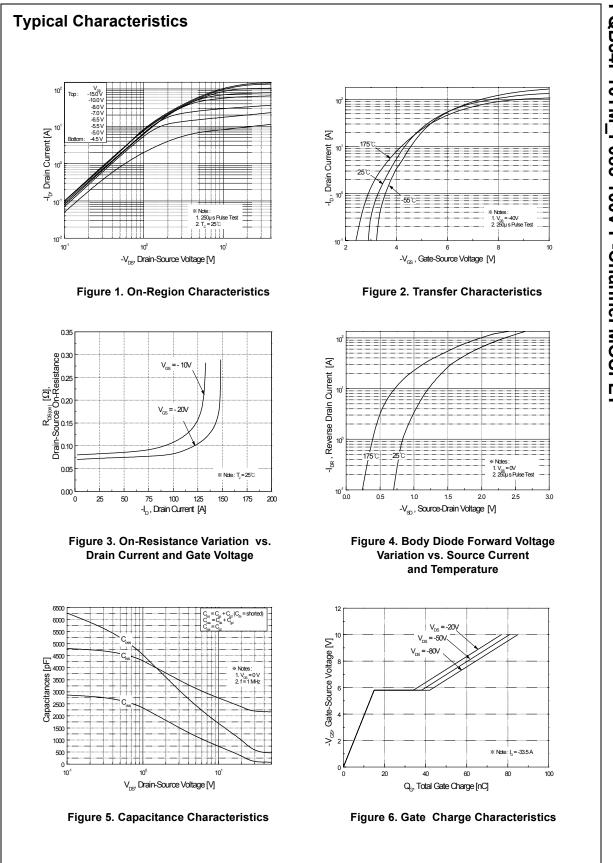
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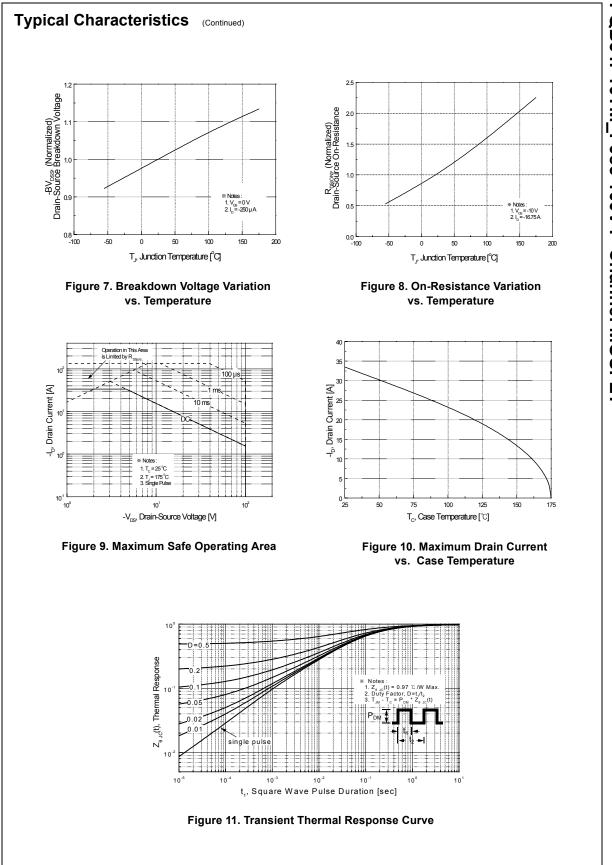
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	Test Conditions		Тур	Max	Units
racteristics					
Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = -250 μA				V
Breakdown Voltage Temperature		-100			v
Coefficient	$I_D$ = -250 µA, Referenced to 25°C		-0.1		V/°C
Zero Gate Voltage Drain Current	V <sub>DS</sub> = -100 V, V <sub>GS</sub> = 0 V			-1	μΑ
Zero Gate Voltage Drain Gurrent	50 0			-10	μA
Gate-Body Leakage Current, Forward				-100	nA
Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = 25 V, V <sub>DS</sub> = 0 V			100	nA
racteristics					
	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250 μA	-2.0		-4.0	V
Static Drain-Source		-	0.070		~
On-Resistance	$V_{GS} = -10 \text{ V}, I_D = -16.75 \text{ A}$		0.049	0.06	Ω
Forward Transconductance	$V_{DS}$ = -40 V, $I_{D}$ = -16.75 A (Note 4)		23		S
		1	0040	0010	
					pF
	t = 1.0 MHz				рF
Reverse transier Capacitance			170	220	pF
ng Characteristics					
			25	60	ns
Turn-On Rise Time	55 5		250	510	ns
Turn-Off Delay Time	$R_{\rm G} = 25.02$		160	330	ns
Turn-Off Fall Time	(Note 4, 5)		210	430	ns
Total Gate Charge	V <sub>DS</sub> = -80 V, I <sub>D</sub> = -33.5 A,		85	110	nC
Gate-Source Charge	$V_{GS} = -10 V$		15		nC
	+		45		nC
Gate-Drain Charge	(Note 4, 5)				110
-					110
ource Diode Characteristics a	nd Maximum Ratings	 			110
ource Diode Characteristics ar Maximum Continuous Drain-Source Dic	nd Maximum Ratings				A
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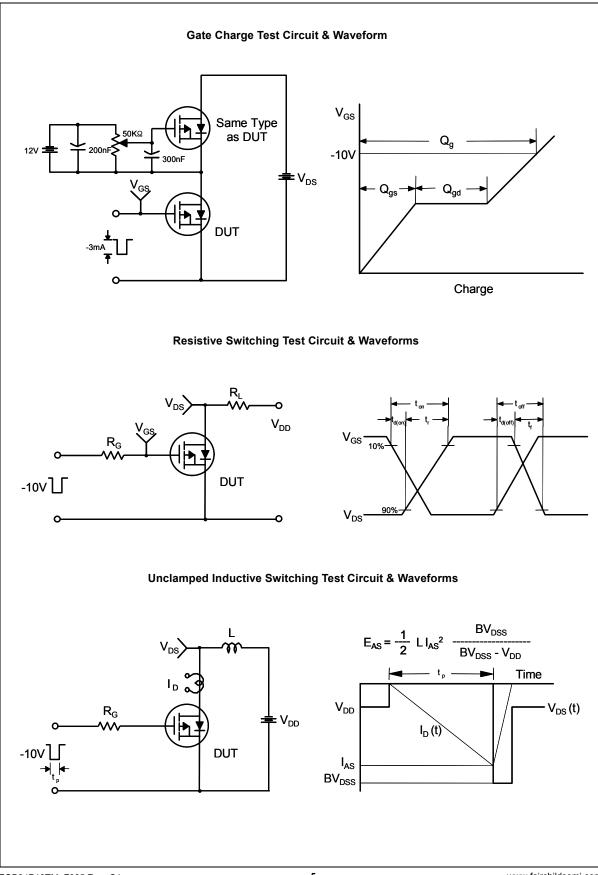
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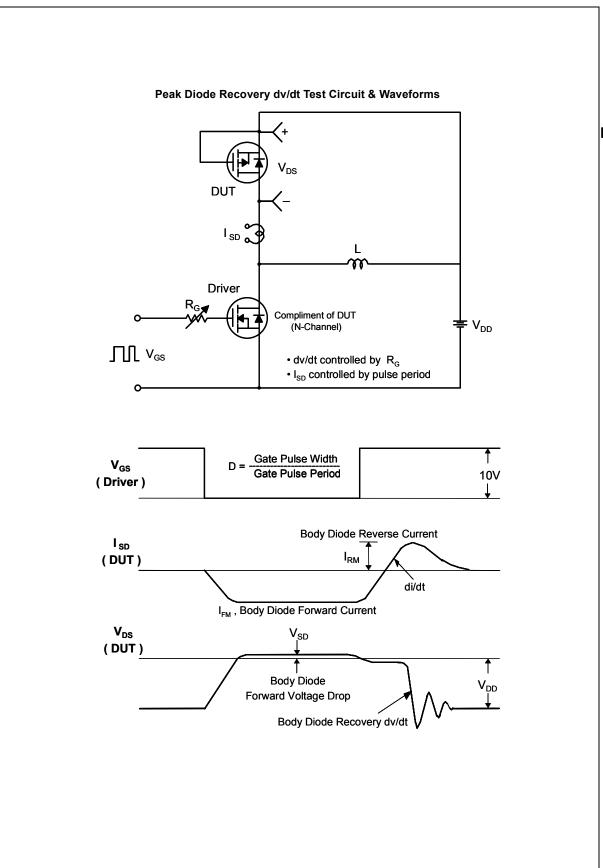
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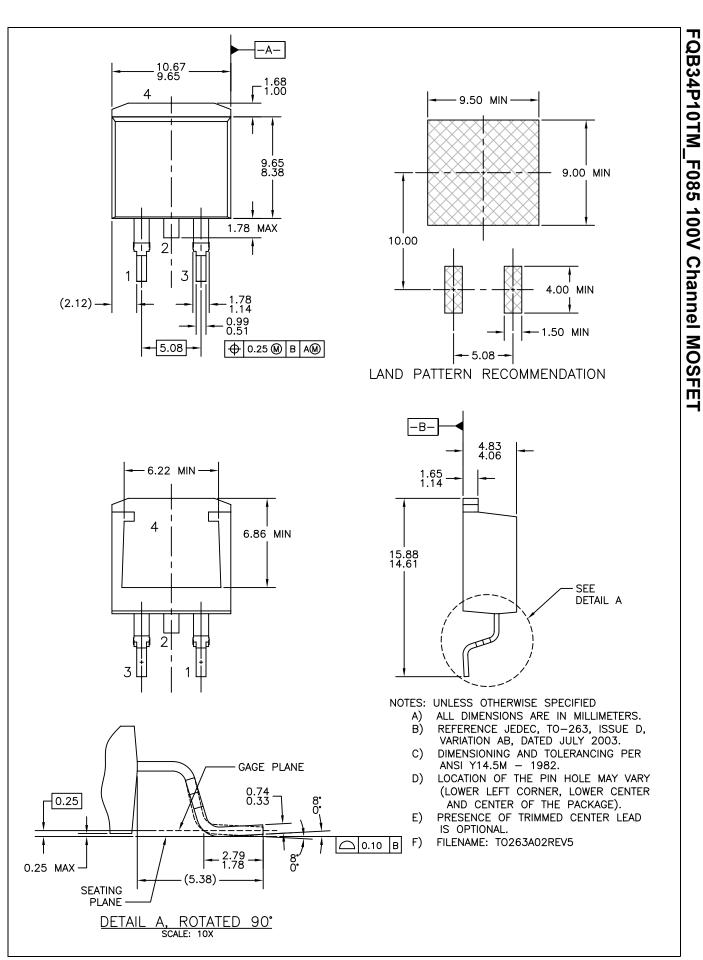
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